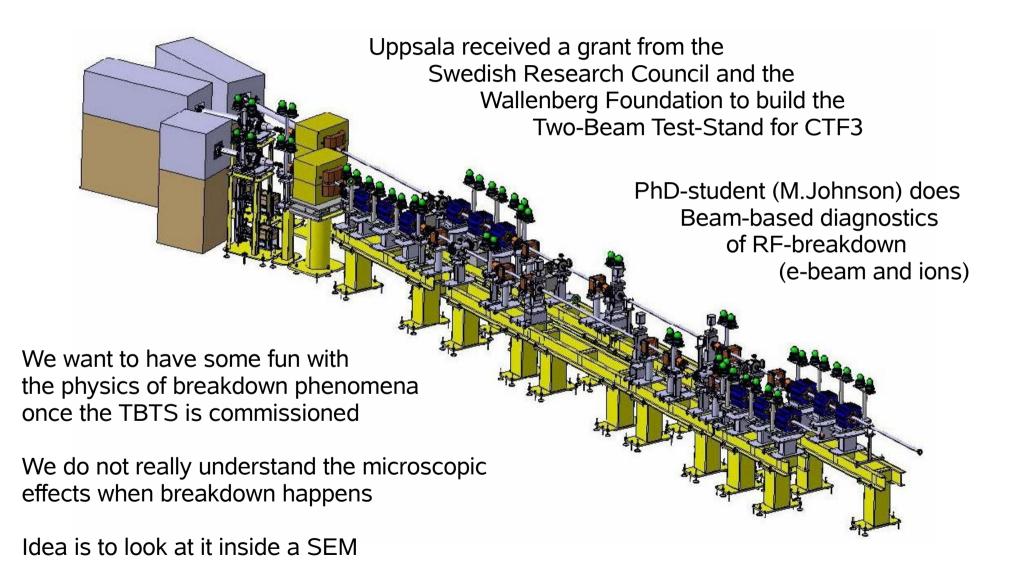
FP7 R&D plans for DC-breakdown measurements inside a Scanning Electron Microscope

Klaus Leifer*, Volker Ziemann[#]

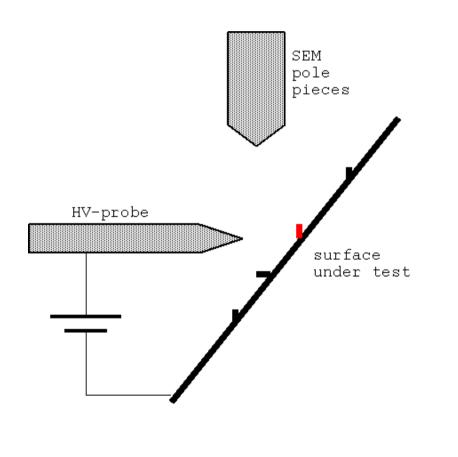
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Uppsala University

Why are we interested?



Vision and Plan



- DC-breakdown test inside SEM
- Select interesting surface structures
- 200 V/µm = 200 MV/m
- See the same spot before/after
 - Fowler-Nordheim (I-V) plots
- Lots of diagnostics
 - secondary electrons and ions
 - fast diodes
 - spectrometer
 - X-rays for element diagnosis
- Cut out surface slices with FIB
- Post-analysis in TEM

Comparison to other work

- Normally
 - breakdown studies are done in a 'global' spirit, covering macroscopic areas
 - and then do post-mortem surface analysis
 - more statistical or averaged results
 - in different vaccum systems
- We want to do breakdown studies
 - on microscopic scale
 - careful analysis of individual events
 - heavily equipped with diagnostics
 - in the same vacuum system

Questions to address

- Influence of surface topography
- What role does surface oxide layer play?
- Which materials constitute the plasma?
- How is the surface affected? Does it get softer, because the breakdown anneals the material?
- What are the time scales involved?
- Classification of breakdown (is there: ions, light, spectral lines,...)
- Does the chemistry change during breakdown?
- When does processing good, and when does it harm?
- Can one observe the processing curve even with single processed spots?

Microscopic Breakdown

- Is the picture developed for superconducting cavities applicable? (J. Knobloch thesis, 1997)
 - field emission current heats and desorbs gas
 - field emission current ionizes gas
 - and generates plasma of which electron disappear
 - 'naked ions' increase surface field
 - and generate a runaway process...
 - where the ions eventually do Coulomb-explosion

Infrastructure in Uppsala

- Ångström Laboratory at Uppsala University
 - Micro-structure lab (msl.angstrom.uu.se)
 - 1 FIB, 4 SEM, 2 TEM, 1 AFM
 - 2000 m² clean room with process and analysis lab
 - Electron microscopy
 - High-voltage
 - Surface physics
 - CAI: Center for Accelerator
 and Instrument Development
 (www.cai.uu.se)



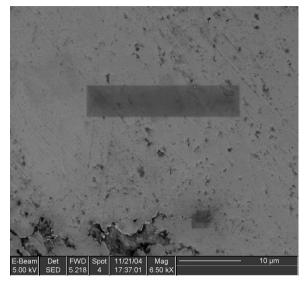
The FIB SEM (FEI Strata DB 235)

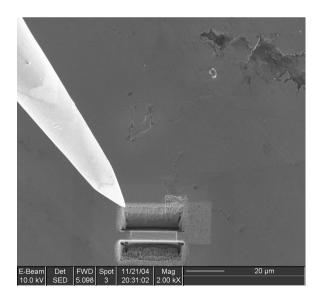


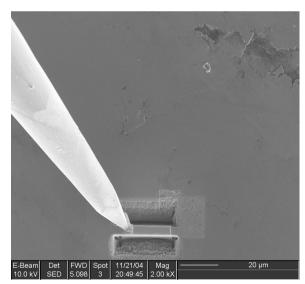
- Vertical SEM
- Diagonal manipulator
- Ion beam in the back
- EDX (big cylinder)
- about cube-foot space
- available flanges
- positioning knobs

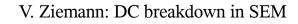
TEM sample preparation in FIB

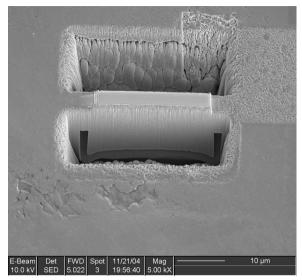


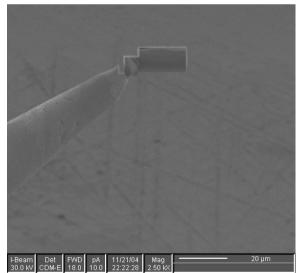






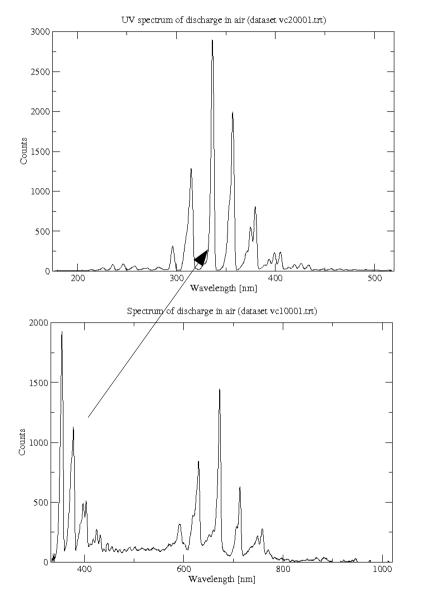






Pictures are shown courtesy of E. Coronel Uppsala University

Preliminaries: Spectra in Air



- Borrowed Ocean Optics spectrometer (S2000 UV+VIS)
- Continuous 20 kV discharge in air at the HV department
- UV: 0.2 eV spacing $\approx O_2$
- No success of identification yet, despite searches in Pearse and Herzberg
- Triggering worked, but not used in the presented pictures
- Even triggering on light (LDR)
- too long integration time

Technical Issues

- Put high-voltage (< kV) on the manipulator in FIB (asked manufacturer, probably ok)
 - Could use extra remote-controlled XY-motion stage inside the FIB as backup solution
- Elektrostatic forces on the thin needle will bend it which will affect pin-positioning accuracy
- Timing and triggering
- Controlling the energy in breakdown

Conclusion

- Want to participate in the later physics program of the TBTS after commisioning
- Understand what happens during breakdown on a microscopic scale
- We have a powerful infrastructure at home in Ångström laboratory at Uppsala University which constitutes a strong multi-disciplinary infrastructure
- Help and collaborations are certainly welcome